

Notice of References Cited	Application/Control No. 09/486,715		Applicant(s)/Patent Under Reexamination BEVAN ET AL.	
	Examiner Yelena G. Gakh, Ph.D.		Art Unit 1743	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,192,509	03-1993	Surjaatmadja et al.	422/75
	B	US-			
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	M	US-			

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